# State-of-the-Art in Room-Temperature THz Mixers and Direct Detectors

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# **Broadband Mixers**

A frequency mixer – mix a high frequency signal with a local oscillator reference to generate a copy of the signal at a lower frequency for spectral analysis.



Goals - Optimize input, LO and IF coupling, reduce noise, filter other frequencies, reduce LO power required, increase bandwidth, ....

Schottky diodes at RT, but Superconductors yield far better sensitivity when cooled!

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# Make metallizations as thick as possible to reduce series resistance





**Airbridge Processing** 

# **Broadband Mixers**

5000 Low conversion 4500 S 4000 loss Ē 3500 - 5 dB (DSB) at **Tmix (matched** 3000 100 GHz 2500 - 10 dB at 640 2000 GHz 1500 **Broad IF** ۲ 1000 bandwidth 500 – > 40 GHz for 0 200 600 1000 400 800 mixer at 600 0 GHz Frequency (GHz) LO Power 2-7 mW ◆ VDI - Subharmonic - Flip Chip ■ VDI - Subharmonic - Integrated Typical ◆ VDI - Fundamental - Flip Chip ■ VDI - Fundamental - Integrated

> 440-660 GHz Mixer



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# WR-1.2SHM – 870 GHz Mixer

- Configuration Amp+X4+X3+SHM
  - Amp → 1W at 36.25 GHz
  - Q145 → 100 mW at 145 GHz
  - WR-2.2X3 → 2.5 mW at 435 GHz
- T<sub>mix</sub> = 3500 K (DSB)
   IF SWR 2.25:1
- L<sub>mix</sub> = 12 dB (DSB)



# Subharmonic Mixer Design

- Use Tunerless Broadband Mixer Design
  - Broadband
- Anti-parallel Subharmonic Mixer
  - LO at ½ RF
  - No external diplexer needed
  - LO noise suppression
  - Relatively low IF impedance
- Disadvantages
  - requires larger LO power
  - difficult to bias diodes



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## **THz Direct Detectors**



# **Rectifier Responsivity**



# **Broadband Zero-Bias Detectors**

WR-6.5ZBD



Note: this is external responsivity, including coupling factor



#### **Big Challenge with Rectifiers: THz Impedance Matching**



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# **Fully Planaraized Processing**

#### • Fabricate Schottky diode in driving gap of planar antenna





# **Planar Antenna Coupling**

#### (Antenna must be very small)



#### **The Ultimate Potential of Rectifiers**



### **Optical Responsivity & NEP Measurement**



#### 650-GHz Plane-Wave Set-UP



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# **NE\DeltaT** Set-Up



# Measuring NE $\Delta$ T



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# **THz Thermal Detectors**

- All of these utilize the change in some physical property caused by the temperature rise associated with absorption of radiation.
- (1) Bolometer: change in resistance of a solid: (1/R) dR/dT
  - (2) Golay cell: change in volume of gas
  - (3) Pyroelectric detector: change in dielectric constant:

 $\kappa_{P} = dP_{e}/dT$ ,  $P_{e}$  being the macroscopic electric polarization

- These thermal detectors must be electrically biased.
- Big challenge at THz frequencies in the terrestrial environment is the ubiquitous background infrared radiation.



#### **Pyroelectric Detector Analysis**

Inherently an AC effect since it depends on polarization current, dP<sub>E</sub>/dT

$$i = A \frac{dP_E}{dT} \cdot \frac{dT}{dt} \equiv A \cdot \kappa_P \cdot \frac{dT}{dt} = A \cdot \kappa_P \cdot \frac{d\Delta T}{dt}$$

• For *slow* sinusoidally modulated input power,  $P_{in}(\omega) = P_0 \sin(\omega t)$ , we expect sinusoidal temperature deviation  $\Delta T(t)$  as well

$$i = A \cdot \kappa_P \cdot \omega \cdot \Delta T \cos(\omega t)$$

• Assume that in steady state the rise in temperature caused by absorbed THz radiation  $P_{in}$ , is matched by a thermal radiation to background (mostly in the IR region for  $T_0 = 300$  K). Hence

$$\Delta T = \frac{P_{in}}{G}$$

#### Where G is the radiative thermal conductance

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### **Pyroelectric Detector Analysis (cont)**

So the instantaneous signal and

Noise terms: (1) thermal noise from generalized Nyquist, and
(2) radiation fluctuations expressed as temperature

$$<(\Delta i)^{2} >= \frac{4k_{B}T_{N}}{R} + (A \cdot \kappa_{P}\omega)^{2} < (\Delta T)^{2} >$$
Johnson Nyquist,  
 $T_{N} \Rightarrow$  noise temp including TIA
Temperature Fluctuations

 But any body close to thermal equilibrium with a bath at temp T<sub>0</sub> has fluctuations (upcoming HW problem)

$$< (\Delta T)^2 > \approx \frac{4k_B T_0^2}{G} \Delta f$$

where  $\Delta f$  is the electrical bandwidth

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# **Pyroelectric Detector Analysis (cont)**

• So the electrical signal-to-noise ratio becomes

$$SNR = \frac{i_{s}^{2}}{\langle (\Delta i)^{2} \rangle}$$
$$= \frac{P_{0}^{2}}{4k_{B}T_{N}BG^{2} / [R(\kappa_{p}A\omega)^{2}] + 4k_{B}T^{2}GB}$$

Solving for the NEP, we get

$$NEP = \sqrt{4k_B T_0^2 G \{1 + [T_N G / T_0^2 R (\kappa_p A \omega)^2]\}}$$

• This is a very interesting expression with a fundamental leading term that is the limiting value with  $\omega$ ,  $\kappa_{p}$ , or both, are large enough

$$NEP \rightarrow \sqrt{4k_B T_0^2 G}$$

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# **Radiative Thermal Conductance Limit**

• So thermal-noise limit can be computed for a best-case scenario of thermal radiative transfer only: Stefan-Boltzman law

 $P_{rad} = \varepsilon A \sigma T^4$   $\sigma \Rightarrow$  Stefan Constant (5.67x10<sup>-8</sup> [MKSA])

$$\frac{dP}{dT} \equiv G = 4 e \sigma A T^{-3} = 1.5 \times 10^{-4} \text{ W/K} \text{ (assuming emissivity e = 1.0,} and A = 0.25 \text{ cm}^2\text{)}$$

• So 
$$NEP \rightarrow \sqrt{4k_B T_0^2 G} = 2.8 \times 10^{-11} \text{ W/Hz}^{1/2}$$

• Bolometers are already operating near this value, but pyroelectric detectors have a ways to go

# **Effect of Thermal Time Constant**

- A disadvantage of all THz thermal detectors (compared to rectifiers) is that they have a thermal time constant which generally limits the electrical bandwidth to relatively low values and introduces a sensitivity-bandwidth tradeoff.
- Where does thermal time constant come from ? Fourier's Law, and conservation of energy:  $\overrightarrow{J_Q} = -K\overrightarrow{\nabla}T$   $-\overrightarrow{\nabla}\cdot\overrightarrow{J_Q} = C_V\frac{\partial T}{\partial t} \rho_Q$

K = thermal conductivity;  $C_v$  = specific heat capacity;  $\rho_Q$  = heat generation density

- In simplest cases, thermal time constant,  $\tau_T = (C_V \cdot V)/(K \cdot L_{th}) \equiv C_T/G$ where V is the volume of the thermal device,  $L_T$  is the thermal path length,  $C_T$  is the thermal capacitance, and G is the thermal conductance
- What happens to a pyroelectric detector when the input power modulation frequency approaches  $1/\tau_{T}$  ?
- Intuitively, we expect signal and the temperature-related fluctuations to roll-off in classic "single-pole" fashion.

#### **Correction to NEP**

• Hence:  

$$\overline{i_s^2} = \frac{(A \cdot \kappa_P \cdot \omega P_0)^2}{2G^2} \rightarrow \frac{(A \cdot \kappa_P \cdot \omega P_0)^2}{2G^2(1 + \omega^2 \tau_T^2)}$$

$$(A \cdot \kappa_P \omega)^2 < (\Delta T)^2 > \rightarrow \frac{(A \cdot \kappa_P \omega)^2}{1 + \omega^2 \tau_T^2} < (\Delta T)^2 > \omega^2 \tau_T^2$$

• But the Johnson-Nyquist noise is not affected, so that the NEP becomes:

$$NEP = \sqrt{4k_{B}T_{0}^{2}G\left\{1 + \frac{T_{N}G(1 + \omega^{2}\tau^{2})}{T_{0}^{2}R(\kappa_{p}A\omega)^{2}}\right\}}$$

• This has a more useful (and realistic high-frequency limit)

$$NEP \to \sqrt{4k_B T_0^2 G \left\{ 1 + \frac{T_N G \tau^2}{T_0^2 R(\kappa_p A)^2} \right\}} = \sqrt{4k_B T_0^2 G \left\{ 1 + \frac{T_N C_T^2}{T_0^2 R G(\kappa_p A)^2} \right\}}$$

This interesting expression will be addressed further in the laboratory write-up

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#### **Best THz Pyroelectric to Date**

